



## FINAL PRODUCT/PROCESS CHANGE NOTIFICATION Generic Copy

## 13 Nov 2009

SUBJECT: ON Semiconductor Final Product/Process Change Notification # 16361

TITLE: Addition of ON Semiconductor Gresham Fab for CAT24C02 2K-bit I<sup>2</sup>C Serial EEPROM

PROPOSED FIRST SHIP DATE: The production shipments will be available: January 1st, 2010. <u>Existing Customers</u> will have until April 1<sup>st</sup>, 2010 to qualify Gresham die.

AFFECTED CHANGE CATEGORY(S): CAT24C02 (all packages, all temperatures)

#### AFFECTED PRODUCT DIVISION(S): Catalyst Group

#### FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact your local ON Semiconductor Sales Office or Denisa Stefan<a>denisa.stefan@onsemi.com</a>>

**SAMPLES:** CAT24C02 in SOIC and TSSOP packages available: **November 25, 2009** For other packages samples availability, see <u>Affected Device List</u> on Page #3. Contact your local ON Semiconductor Sales Office.

**ADDITIONAL RELIABILITY DATA:** Available upon request. Contact your local ON Semiconductor Sales Office or Tony Luciani</f>
(ffxyjj@onsemi.com)

#### **NOTIFICATION TYPE:**

Final Product/Process Change Notification (FPCN)

Final change notification sent to customers. FPCNs are issued at least 90 days prior to implementation of the change.

ON Semiconductor will consider this change approved unless specific conditions of acceptance are provided in writing within 30 days of receipt of this notice. To do so, contact your local ON Semiconductor Sales Office.

#### **DESCRIPTION AND PURPOSE:**

This change allows the addition of the ON Semiconductor wafer manufacturing facility in Gresham, Oregon, USA, ("Gresham") to provide internal additional capacity. The current CAT24C02 product is fabricated at the OKI Semiconductor, Japan 6-inch Fab in a 0.35um CMOS process. The new CAT24C02 die will be fabricated at the Gresham 8-inch Fab in a 0.35um CMOS process. This will provide increased die capacity to meet our growing demand, while maintaining 100% backward compatibility to the previous CAT24C02 die revision.

The CAT24C02 Gresham die will be assembled in fully RoHS-compliant packages at the ON Semiconductor facility, OSPI – Philippines (SOIC packages) and at existing external assembly contractors, UTAC - Thailand and STARS – Thailand (all packages).



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Test	Conditions	Lot Number	Sample Size	168hrs	408hrs	1000hrs		
HTOL	408hrs, 150C release							
High Temp	Per JA108	EGF09090	77	Pass	Pass	Pass		
Op Life	Tritemp test before and after							
		Lot Number	Sample Size	24hrs			-	
ELFR	Per AEC-Q100-008							
Early Life	HTOL conditions, 24hrs, 150C	EGF09090	800	Pass				
Failure Rate	Room/Hot testing before and after							
		Lot Number	Sample Size	100k	200k	300k	400k	500k
EDR	1M Cycles	EGF09090	77	Pass	Pass	Pass	Pass	Pass
NVM Endurance	Per JESD22-A103/Q100-005							
	Room/Hot test before and after	Lot Number	Sample Size	600k	700k	800k	900k	1M
		EGF09090	77	Pass	Pass	Pass	Pass	Pass
		Data	Lot Number	Sample Size	168hrs	336hrs	500hrs	1000hrs
EDR	1000hrs, 150C	"00"	EGF09090	77	Pass	Pass	Pass	Pass
NVM Data	Cycling Precon to 100k							
Retention	Per Q100-005	Data	Lot Number	Sample Size	168hrs	336hrs	500hrs	1000hrs
	Room/Hot test before and after	"FF"	EGF09090	77	Pass	Pass	Pass	Pass
		Lot Number	Sample Size	500V	1000V	1500V	2000V	· · · · · · · · · · · · · · · · · · ·
ESD	Human Body Model	EGF09090	3/level	Pass	Pass	Pass	Pass	
	AEC Q100-002	PH1020346A	3/level	Pass	Pass	Pass	Pass	
		Lot Number	Sample Size	2500V	3000V	3500v	4000v	
		EGF09090	3/level	Pass	Pass	Pass	Pass	
		PH1020346A	3/level	Pass	Pass	Pass	Pass	
		Lot Number	Sample Size	50V	100V	150V	200V	
ESD	Machine Model	EGF09090	3/level	Pass	Pass	Pass	Pass	
	AEC Q100-003	PH1020346A	3/level	Pass	Pass	Pass	Pass	
		Lot Number	Sample Size	250V	500V	750V	1000V	1250V
ESD	Charged Device Model							
	AEC Q100-011	EGF09090	3/level	Pass	Pass	Pass	Pass	Pass
		Lot Number	Sample Size	100ma	100ma			
LU	Latch Up			25C	125C			
	per AEC-Q100-004	EGF09090	6	Р	Р			
	Room / Hot testing after LU test							
		Package	Lot Number	Sample Size	Result			
GL	Gate Leakage							
	Per AEC-Q100-006	SOIC	EGF09090	6	Pass			
	Room testing before and after	TSSOP	EGF09090	6	Pass			
	6 units per sample							

## RELIABILITY DATA SUMMARY:



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#### ELECTRICAL CHARACTERISTIC SUMMARY:

The CAT24C02 Gresham die is 100% compatible to OKI die product Revision G within the same data sheet parameters. The device data sheet is available at: <a href="http://www.onsemi.com/pub\_link/Collateral/MD-1115-D.PDF">http://www.onsemi.com/pub\_link/Collateral/MD-1115-D.PDF</a>

A detailed characterization report is available upon request.

#### CHANGED PART IDENTIFICATION:

The orderable part number (OPN) for the new Gresham die will have the letter "A" added at the end of the part number. See <u>Affected Device List</u>.

The top package marking for the new Gresham die versus current marking for the OKI die is shown in the attached Appendix.

The Gresham die will also be identified though a 2-digit country code for wafer fabrication (CS: US) on the label of the packaging box. OKI die is identified on the label of the packaging box as CS: Japan.

## AFFECTED DEVICE LIST

Part Number - OKI die	Part Number - Gresham die	Samples Avail Date
CAT24C02LI-G	CAT24C02LI-GA	5-Dec-09
CAT24C02WI-GT3	CAT24C02WI-GT3A	25-Nov-09
CAT24C02YI-GT3	CAT24C02YI-GT3A	25-Nov-09
CAT24C02VP2I-GT3	CAT24C02VP2IGT3A	20-Dec-09
CAT24C02ZI-GT3	CAT24C02ZI-GT3A	20-Dec-09
CAT24C02TDI-GT3	CAT24C02TDI-GT3A	20-Dec-09
CAT24C02LE-G	CAT24C02LE-GA	20-Dec-09
CAT24C02WE-GT3	CAT24C02WE-GT3A	20-Dec-09
CAT24C02YE-GT3	CAT24C02YE-GT3A	20-Dec-09
CAT24C02VP2E-GT3	CAT24C02VP2EGT3A	20-Dec-09
CAT24C02ZE-GT3	CAT24C02ZE-GT3A	20-Dec-09
CAT24C02TDE-GT3	CAT24C02TDE-GT3A	20-Dec-09



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## Appendix Package Marking - Gresham die versus actual OKI die

## SOIC 8 (W)

Current Marking: OKI die



#### FRONT SIDE MARK:

- 1: Assembly location code
- 2: Mark "4" for (lead finish NiPdAu)
- 3: Product Revision: Fixed as "G"
- 4-9: Product Name: "24C02W"
- 10: Temp Range (I=Industrial; E=Extended)
- 11: Production Year (last digit)
- 12: Production Month (1-9, A,B,C)
- 13-16: Last four digits of assembly lot number

## TSSOP 8 (Y)

#### Current Marking: OKI die



## FRONT SIDE MARK:

- 1-3: Device Code "C02"
  - 4: Assembly location
- 5: Lead finish
- 6: Production Year
- 7: Production Month
- 8-10: Lot Number

## Gresham die



## FRONT SIDE MARK:

- 1-5: Device Code "24C02"
  - 6: Product Revision Fixed as "H"
  - 7: Assembly Location
  - 8: Production Year
  - 9: Production Month
- 10-12: Lot Number

#### Gresham die



## FRONT SIDE MARK:

- 1-2: Device Code "C1"
- 3: Product Revision Fixed as "H"
- 4: Assembly Location
- 5: Production Year
- 6: Production Month
- 7-9: Lot Number



## TDFN 2x3mm (VP2)

Current Marking: OKI die



## FRONT SIDE MARK:

- 1-2: Device Code
- 3: Assembly location
- 4-6: Lot Number
  - 7: Production Year
  - 8: Production Month

## TSOT-23 5LD (TD)

Current Marking: OKI die marking)

**TOP MARKING:** 



- 1-2 : Device Code
  - 3 : Production Year
  - 4 : Production Month

## **BOTTOM MARKING:**



5 : Assembly location 6-8 : Lot Number

## Gresham die



## FRONT SIDE MARK:

- 1-2: Device Code "C1"
  - 3: Assembly location
- 4-6: Lot Number
  - 7: Production Year
  - 8: Production Month

#### Gresham Die (No bottom



- 1-2. Device Code "C1" 3. Assembly location
- 4-5. Lot number Binary code for date code



## MSOP 8LD (Z)

#### Current top marking: OKI die



1-4. Device Code
 5. Production Year
 6. Production Month
 7. Product Revision

#### Bottom marking



8: Assembly Location 9-11 Lot Number

## PDIP 8 (L)

Current marking: OKI die



#### FRONT SIDE MARK:

- 1: Assembly location code
- 2: Mark "4" for (lead finish NiPdAu)
- 3: Product Revision: Fixed as "G"
- 4-9: Device Code: "24C02W"
- 10: Temp Range (I=Industrial; E=Extended)
- 11: Production Year (last digit)
- 12: Production Month (1-9, A,B,C)
- 13-16: Last four digits of assembly lot number

#### Gresham die:



	1-2.	Device	Code	
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- Production Year
- 4. Production Month
- 5. Assembly location 6-7. Lot Number

No Bottom marking

Gresham die



## FRONT SIDE MARK:

- 1-5: Device Code "24C02"
- 6: Product Revision
- 7: Assembly Location
- 8: Production Year
- 9: Production Month
- 10-12: Lot Number